



ALPHA & OMEGA
SEMICONDUCTOR

AONR21305C

30V P-Channel MOSFET

General Description

- Latest Advanced Trench Technology
- Low $R_{DS(ON)}$
- High Current Capability
- RoHS and Halogen-Free Compliant

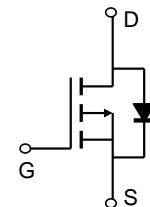
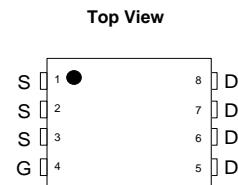
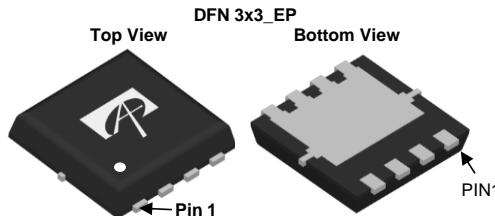
Product Summary

| | |
|-----------------------------------|---------|
| V_{DS} | -30V |
| I_D (at $V_{GS}=-10V$) | -34A |
| $R_{DS(ON)}$ (at $V_{GS}=-10V$) | < 6.5mΩ |
| $R_{DS(ON)}$ (at $V_{GS}=-4.5V$) | < 9.8mΩ |

Applications

- Notebook AC-in Load Switch
- Battery Protection Charge/Discharge

100% UIS Tested
100% R_g Tested



| Orderable Part Number | Package Type | Form | Minimum Order Quantity |
|-----------------------|--------------|-------------|------------------------|
| AONR21305C | DFN 3x3 EP | Tape & Reel | 5000 |

Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

| Parameter | Symbol | Maximum | Units |
|--|----------------|------------|-------|
| Drain-Source Voltage | V_{DS} | -30 | V |
| Gate-Source Voltage | V_{GS} | ± 20 | V |
| Continuous Drain Current ^G | I_D | -34 | A |
| $T_C=100^\circ C$ | | -34 | |
| Pulsed Drain Current ^C | I_{DM} | -210 | A |
| Continuous Drain Current | I_{DSM} | -22 | A |
| $T_A=70^\circ C$ | | -18 | |
| Avalanche Current ^C | I_{AS} | -44 | A |
| Avalanche energy ^C | E_{AS} | 97 | mJ |
| Power Dissipation ^B | P_D | 42 | W |
| $T_C=100^\circ C$ | | 16 | |
| Power Dissipation ^A | P_{DSM} | 5 | W |
| $T_A=70^\circ C$ | | 3.2 | |
| Junction and Storage Temperature Range | T_J, T_{STG} | -55 to 150 | °C |

Thermal Characteristics

| Parameter | Symbol | Typ | Max | Units |
|--|-----------------|-----|-----|-------|
| Maximum Junction-to-Ambient ^A | $R_{\theta JA}$ | 20 | 25 | °C/W |
| Maximum Junction-to-Ambient ^{A,D} | | 45 | 55 | °C/W |
| Maximum Junction-to-Case | $R_{\theta JC}$ | 2.4 | 3 | °C/W |

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|-----------------------------|--|--|------|------------|-----------|------------------|
| STATIC PARAMETERS | | | | | | |
| BV_{DSS} | Drain-Source Breakdown Voltage | $I_D=-250\mu\text{A}$, $V_{GS}=0\text{V}$ | -30 | | | V |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS}=-30\text{V}$, $V_{GS}=0\text{V}$ $T_J=55^\circ\text{C}$ | | | -1 -5 | μA |
| I_{GSS} | Gate-Body leakage current | $V_{DS}=0\text{V}$, $V_{GS}=\pm 20\text{V}$ | | | ± 100 | nA |
| $V_{GS(\text{th})}$ | Gate Threshold Voltage | $V_{DS}=V_{GS}$, $I_D=-250\mu\text{A}$ | -1.3 | -1.8 | -2.3 | V |
| $R_{DS(\text{ON})}$ | Static Drain-Source On-Resistance | $V_{GS}=-10\text{V}$, $I_D=-20\text{A}$ $T_J=125^\circ\text{C}$ | | 5.3 7.4 | 6.5 9 | $\text{m}\Omega$ |
| | | $V_{GS}=-4.5\text{V}$, $I_D=-20\text{A}$ | | 7.7 | 9.8 | $\text{m}\Omega$ |
| g_{FS} | Forward Transconductance | $V_{DS}=-5\text{V}$, $I_D=-20\text{A}$ | | 17 | | S |
| V_{SD} | Diode Forward Voltage | $I_S=-1\text{A}$, $V_{GS}=0\text{V}$ | | -0.7 | -1 | V |
| I_S | Maximum Body-Diode Continuous Current ^G | | | | -34 | A |
| DYNAMIC PARAMETERS | | | | | | |
| C_{iss} | Input Capacitance | $V_{GS}=0\text{V}$, $V_{DS}=-15\text{V}$, $f=1\text{MHz}$ | | 4400 | | pF |
| C_{oss} | Output Capacitance | | | 505 | | pF |
| C_{rss} | Reverse Transfer Capacitance | | | 415 | | pF |
| R_g | Gate resistance | $f=1\text{MHz}$ | | 2.7 | 5.4 | Ω |
| SWITCHING PARAMETERS | | | | | | |
| $Q_g(10\text{V})$ | Total Gate Charge | $V_{GS}=-10\text{V}$, $V_{DS}=-15\text{V}$, $I_D=-20\text{A}$ | | 70 | 110 | nC |
| $Q_g(4.5\text{V})$ | Total Gate Charge | | | 32 | 50 | nC |
| Q_{gs} | Gate Source Charge | | | 10 | | nC |
| Q_{gd} | Gate Drain Charge | | | 16 | | nC |
| $t_{D(\text{on})}$ | Turn-On DelayTime | $V_{GS}=-10\text{V}$, $V_{DS}=-15\text{V}$, $R_L=0.75\Omega$, $R_{\text{GEN}}=3\Omega$ | | 12 | | ns |
| t_r | Turn-On Rise Time | | | 11 | | ns |
| $t_{D(\text{off})}$ | Turn-Off DelayTime | | | 70 | | ns |
| t_f | Turn-Off Fall Time | | | 23 | | ns |
| t_{rr} | Body Diode Reverse Recovery Time | $I_F=-20\text{A}$, $dI/dt=500\text{A}/\mu\text{s}$ | | 15 | | ns |
| Q_{rr} | Body Diode Reverse Recovery Charge | $I_F=-20\text{A}$, $dI/dt=500\text{A}/\mu\text{s}$ | | 34 | | nC |

A. The value of R_{JJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The Power dissipation P_{DSM} is based on $R_{\text{JJA}} \leq 10\text{s}$ and the maximum allowed junction temperature of 150°C . The value in any given application depends on the user's specific board design.

B. The power dissipation P_D is based on $T_{J(\text{MAX})}=150^\circ\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature $T_{J(\text{MAX})}=150^\circ\text{C}$.

D. The R_{JJA} is the sum of the thermal impedance from junction to case R_{JC} and case to ambient.

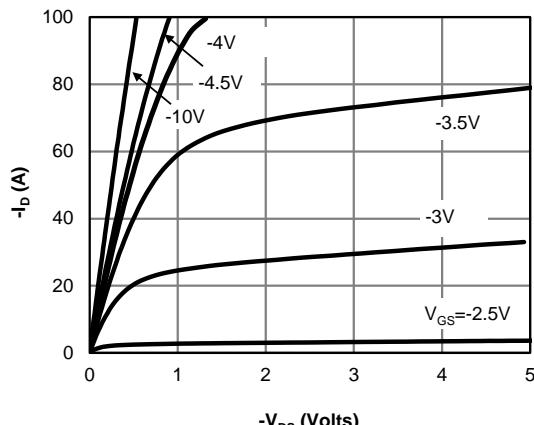
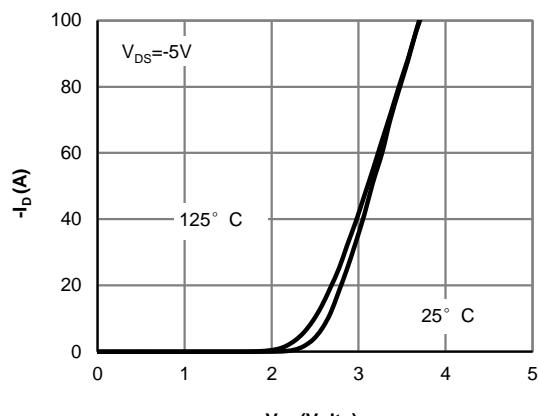
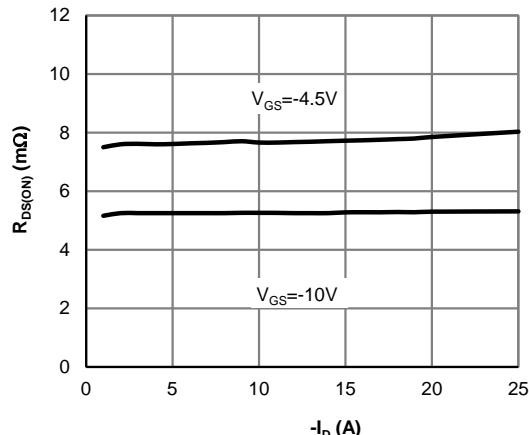
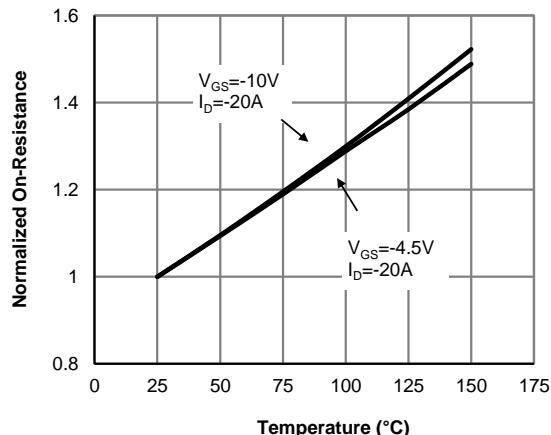
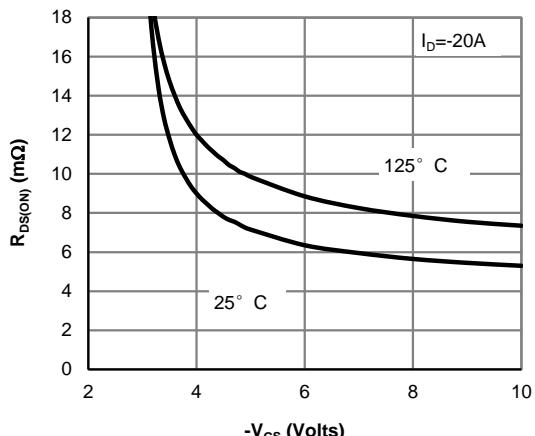
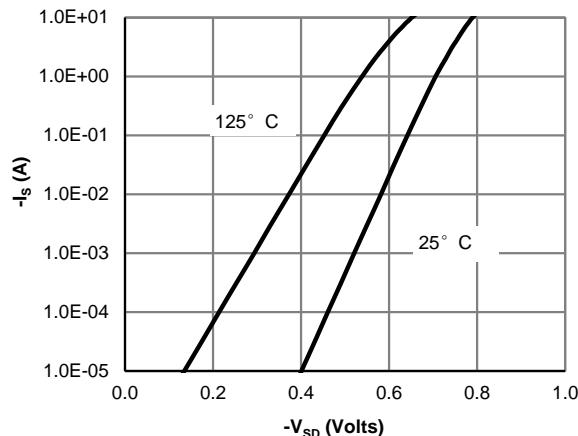
E. The static characteristics in Figures 1 to 6 are obtained using $<300\mu\text{s}$ pulses, duty cycle 0.5% max.

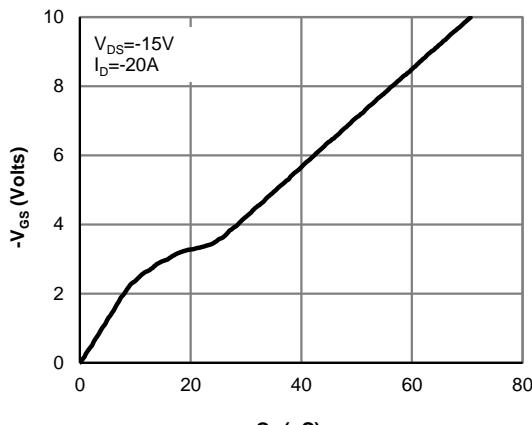
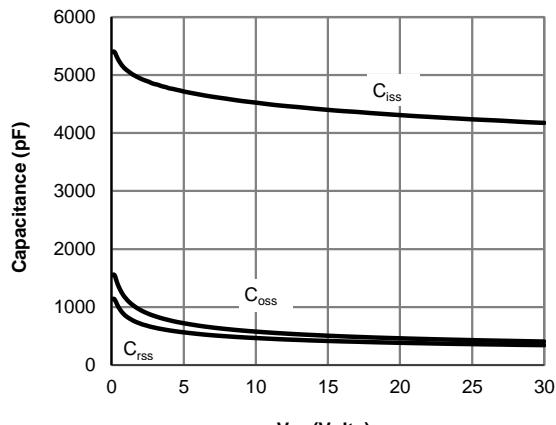
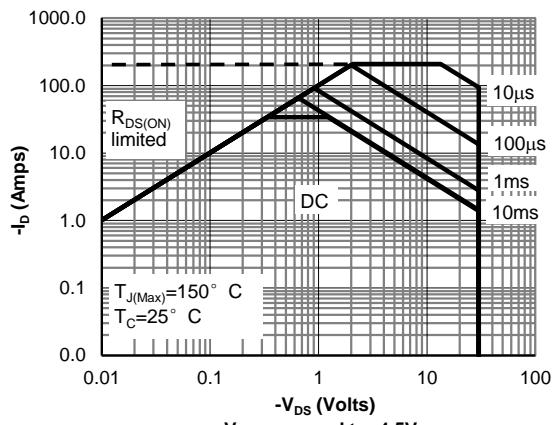
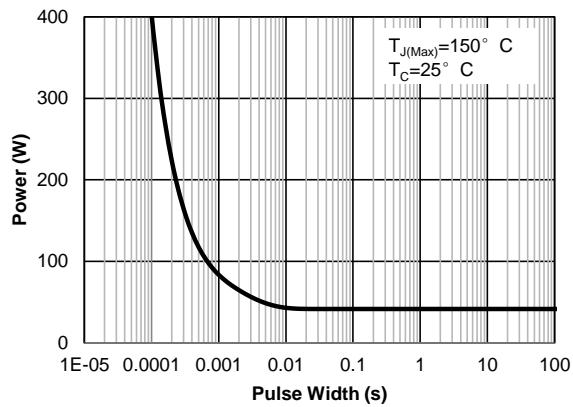
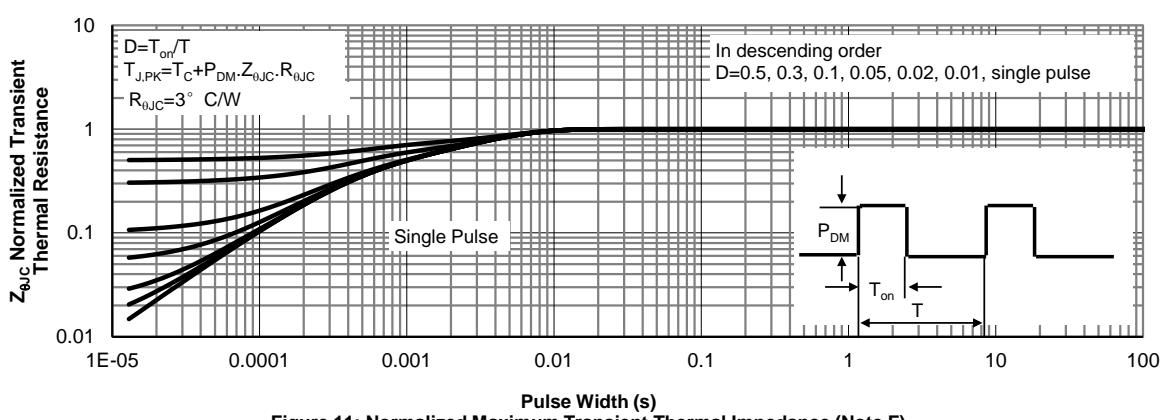
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(\text{MAX})}=150^\circ\text{C}$. The SOA curve provides a single pulse rating.

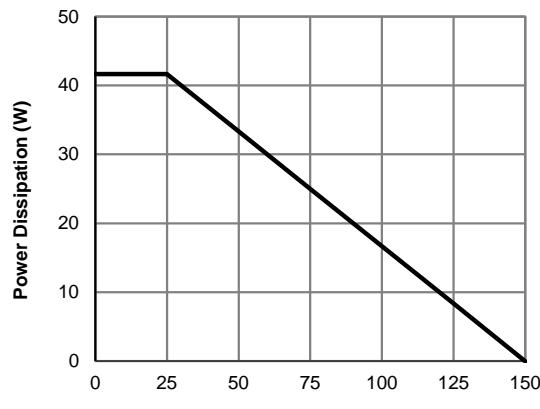
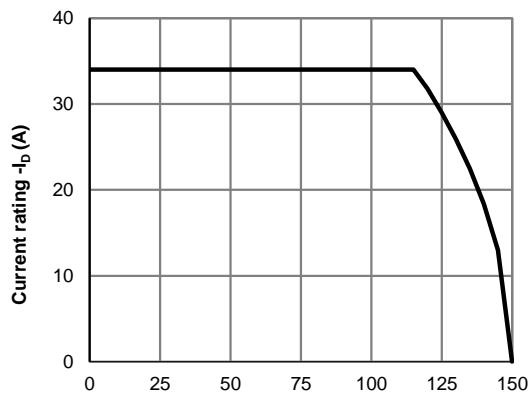
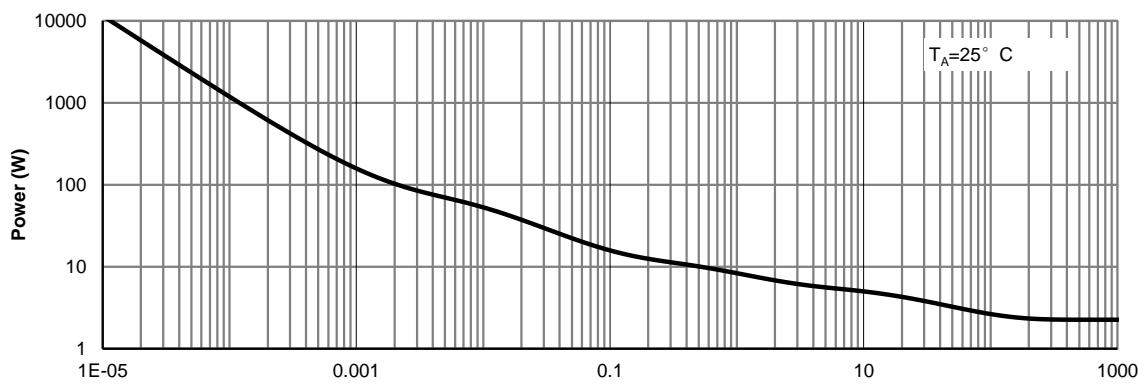
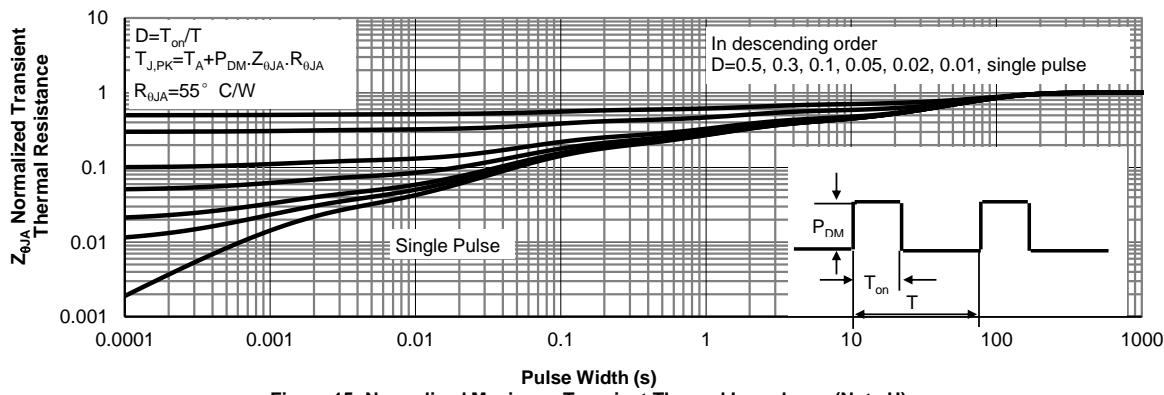
G. The maximum current rating is package limited.

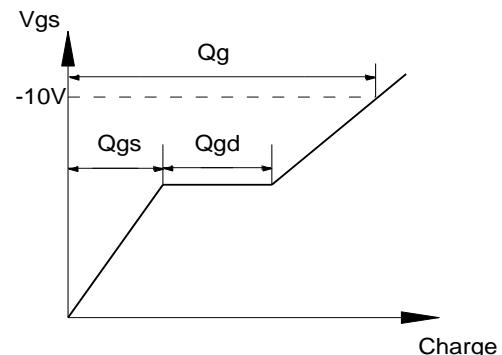
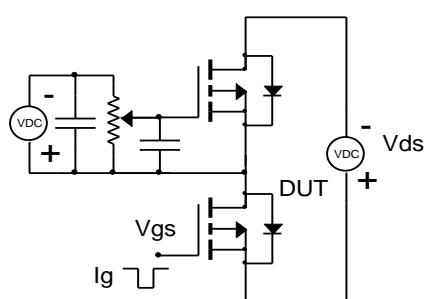
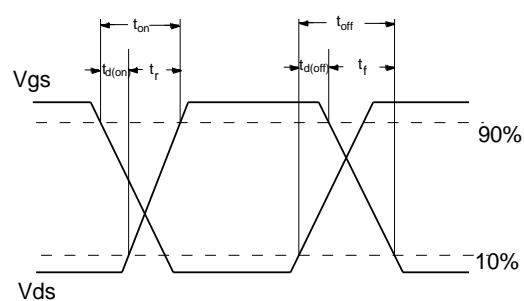
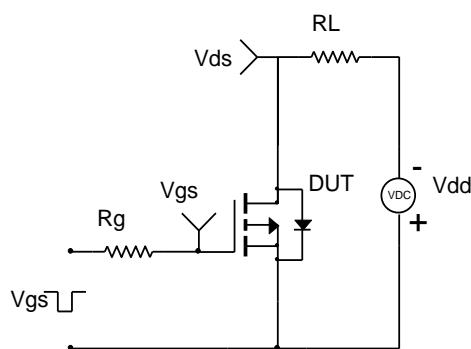
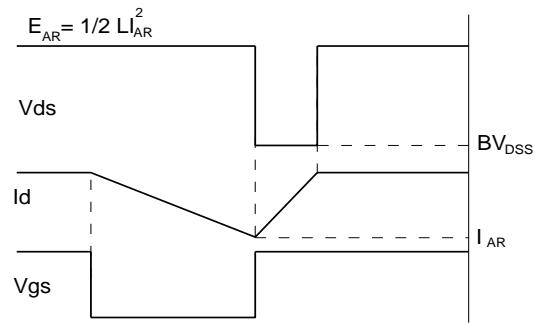
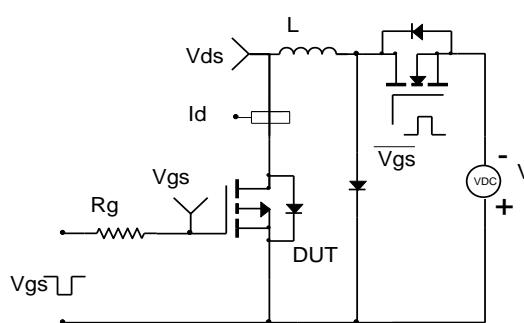
H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

Figure 1: On-Region Characteristics (Note E)

Figure 2: Transfer Characteristics (Note E)

Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

Figure 4: On-Resistance vs. Junction Temperature (Note E)

Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

Figure 6: Body-Diode Characteristics (Note E)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

Figure 7: Gate-Charge Characteristics

Figure 8: Capacitance Characteristics

Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

Figure 12: Power De-rating (Note F)

Figure 13: Current De-rating (Note F)

Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)

Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)

Gate Charge Test Circuit & Waveform

Resistive Switching Test Circuit & Waveforms

Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

Diode Recovery Test Circuit & Waveforms
